TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

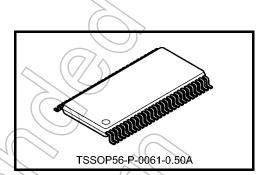
TC74VCX16721FT

Low-Voltage 20-Bit D-Type Flip-Flop with 3.6-V Tolerant Inputs and Outputs

The TC74VCX16721FT is a high-performance CMOS 20-bit D-type flip-flop. Designed for use in 1.8-V, 2.5-V or 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

It is also designed with overvoltage tolerant inputs and outputs up to $3.6\ V\!.$

The TC74VCX16721FT is edge-triggered D-type flip-flop with qualified clock storage. On the positive transition of the clock (CK) input, the device provides true data at the Q outputs if the clock-enable (\overline{CKEN}) input is low. If \overline{CKEN} is high, no data is stored. When the \overline{OE} input is high, the outputs are in a high-impedance state. This device is designed to be used with 3-state memory address drivers, etc.



Weight: 0.25 g (typ.)

All inputs are equipped with protection circuits against static discharge.

Features

- Low-voltage operation: V_{CC} = 1.8 to 3.6 V
- High-speed operation: $t_{pd} = 3.5 \text{ ns (max)} (V_{CC} = 3.0 \text{ to } 3.6 \text{ V})$

 $: t_{pd} = 4.4 \text{ ns (max) (VCC} = 2.3 \text{ to } 2.7 \text{ V)}$

 $t_{pd} = 8.8 \text{ ns (max) (VCC} = 1.8 \text{ V)}$

• Output current: $I_{OH}/I_{OL} = \pm 24 \text{ mA (min)} (V_{CC} = 3.0 \text{ V})$

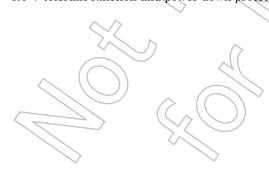
 $: I_{OH}/I_{OL} = \pm 18 \text{ mA (min) (V}_{CC} = 2.3 \text{ V)}$

 $: I_{OH}/I_{OL} = \pm 6 \text{ mA (min)} (V_{CC} = 1.8 \text{ V})$

- Latch-up performance: -300 mA
- ESD performance: Machine model ≥ ±200 V

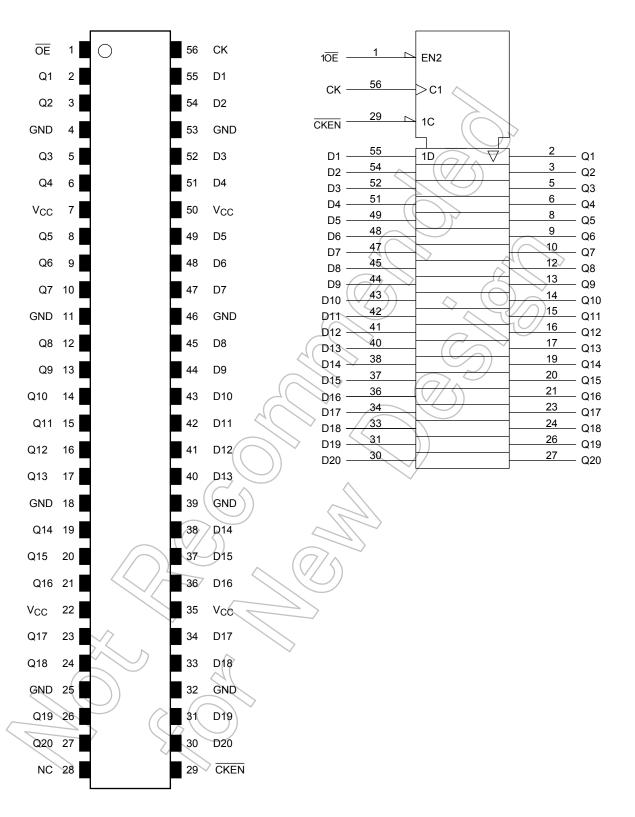
Human body model $\geq \pm 2000 \text{ V}$

- Package: TSSOP
- 3.6-V tolerant function and power-down protection provided on all inputs and outputs



Pin Assignment (top view)

IEC Logic Symbol



Truth Table (each flip-flop)

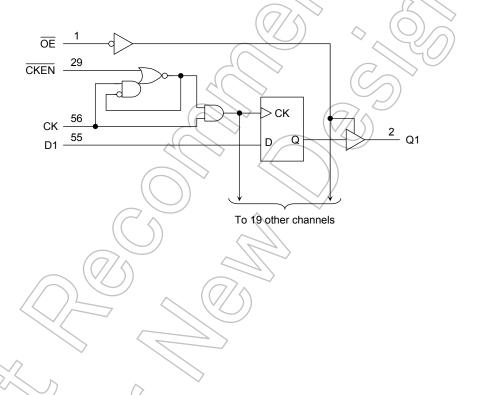
	Inputs					
ŌĒ	CKEN	CK	D	Q		
L	Н	Х	Х	Q0		
L	L		Н	Н		
L	L		L	L		
L	L	L or H	Х	Q0		
Н	X	X	Х	Z		

X: Don't care

Z: High impedance

Qn: No change

System Diagram



Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit	
Power supply voltage	V_{CC}	-0.5 to 4.6	V	
DC input voltage	V _{IN}	−0.5 to 4.6	V	
		-0.5 to 4.6 (Note 2)	4	
DC output voltage	V _{OUT}	-0.5 to V _{CC} + 0.5 (Note 3)	V	
Input diode current	I _{IK}	-50	mA	
Output diode current	lok	±50 (Note 4)	mA	
DC output current	lout	±50	mA	
Power dissipation	P _D	400	mW	
DC V _{CC} /ground current per supply pin	I _{CC} /I _{GND}	±100	(mA)	
Storage temperature	T _{stg}	-65 to 150	°C	

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: OFF state

Note 3: High or low state. IOUT absolute maximum rating must be observed.

Note 4: $V_{OUT} < GND$, $V_{OUT} > V_{CC}$

Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	y _{cc}	1.8 to 3.6	V
Tower supply voltage		1,2 to 3.6 (Note 2)	V
Input voltage	V _{IN}	-0.3 to 3.6	V
Output voltage	Vaux	0 to 3.6 (Note 3)	V
Output voltage	Vout	0 to V _{CC} (Note 4)	V
	^	±24 (Note 5)	
Output current	I _{OH} /I _{OL}	±18 (Note 6)	mA
\wedge (\bigcirc)		±6 (Note 7)	
Operating temperature	Topr	-40 to 85	°C
Input rise and fall time	dt/dv	0 to 10 (Note 8)	ns/V

Note 1: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either V_{CC} or GND.

Note 2: Data retention only

Note 3: OFF state

Note 4: High or low state

Note 5: $V_{CC} = 3.0 \text{ to } 3.6 \text{ V}$

Note 6: $V_{CC} = 2.3 \text{ to } 2.7 \text{ V}$

Note 7: $V_{CC} = 1.8 \text{ V}$

Note 8: $V_{IN} = 0.8$ to 2.0 V, $V_{CC} = 3.0$ V



Electrical Characteristics

DC Characteristics (Ta = -40 to 85° C, 2.7 V < $V_{CC} \le 3.6$ V)

Character	istics	Symbol	Test Co	ondition	V _{CC} (V)	Min	Max	Unit							
Input voltage	H-level	V _{IH}	_	_	2.7 to 3.6	2.0	_	V							
input voitage	L-level	V _{IL}	_	_	2.7 to 3.6	_	0.8	V							
				$I_{OH} = -100 \mu A$	2.7 to 3.6	V _{CC} - 0.2	_								
	H-level	V _{OH}	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -12 mA	//2.7	2.2	_								
				I _{OH} = -18 mA	3.0	2.4	_								
Output voltage				I _{OH} = -24 mA	3.0	2.2	_	V							
Llavel		VoL	V _{IN} = V _{IH} or V _{IL}	$I_{OL} = 100 \mu\text{A}$	2.7 to 3.6		0.2								
	L-level			I _{OL} = 12 mA	2.7	4	0.4								
	L-level		VOL	VOL	VOL	VOL	VOL	VOL	VOL	AIM — AIH OL AIT	I _{OL} = 18 mA	3.0		0.4	
				$I_{OL} = 24 \text{ mA}$	3.0	D) -	0.55								
Input leakage curre	ent	I _{IN}	V _{IN} = 0 to 3.6 V		2.7 to 3.6	4	±5.0	μΑ							
3-state output OFF	state current	I _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = 0 to 3.6 V		2.7 to 3.6	>_	±10.0	μА							
Power-off leakage	current	l _{OFF}	V_{IN} , $V_{OUT} = 0$ to 3.6 V			_	10.0	μА							
Quiescent supply current		loo	V _{IN} = V _{CC} or GND		2.7 to 3.6	_	20.0								
		Icc	V _{CC} ≤ (V _{IN} , V _{OUT}) ≤3.6 V		2.7 to 3.6	_	±20.0	μΑ							
Increase in I _{CC} per	input	Δlcc	$V_{IH} = V_{CC} - 0.6 V$		2.7 to 3.6	_	750								

DC Characteristics (Ta = -40 to 85°C, 2.3 V ≤ V_{CC} ≤ 2.7 V)

Characteris	tics	Symbol	Test Co	ondition	V _{CC} (V)	Min	Max	Unit	
Input voltage	H-level	ViH			2.3 to 2.7	1.6	_	V	
Input voltage	L-level	VIL))	2.3 to 2.7	_	0.7	V	
		>		I _{OH} = -100 μA	2.3 to 2.7	V _{CC} - 0.2	_		
	H-level	V _{OH}	VIN = VIH or VIL	$I_{OH} = -6 \text{ mA}$	2.3	2.0	_		
	N n			$I_{OH} = -12 \text{ mA}$	2.3	1.8	_		
Output voltage				$I_{OH} = -18 \text{ mA}$	2.3	1.7	_	V	
				I _{OL} = 100 μA	2.3 to 2.7	_	0.2		
	L-level	> VoL	> VoL	$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OL} = 12 \text{ mA}$	2.3	_	0.4	
	(100		$I_{OL} = 18 \text{ mA}$	2.3	_	0.6		
Input leakage curren	t	\h\	$V_{IN} = 0$ to 3.6 V		2.3 to 2.7		±5.0	μА	
3-state output OFF s	state current	loz	$V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = 0$ to 3.6 V		2.3 to 2.7	_	±10.0	μА	
Power-off leakage co	urrent	l _{OFF}	V_{IN} , $V_{OUT} = 0$ to 3.6 V		0	_	10.0	μА	
Quiescent supply current		loo	V _{IN} = V _{CC} or GND		2.3 to 2.7		20.0	μА	
Quiescent supply cu	II GIIL	V _{CC} ≤ (V _{IN} , V _{OUT}) ≤ 3		V	2.3 to 2.7	-	±20.0	μΑ	

DC Characteristics (Ta = -40 to 85°C, 1.8 V \leq V $_{CC}$ < 2.3 V)

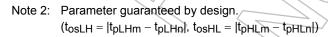
Characteris	stics	Symbol	Test Co	ondition	V _{CC} (V)	Min	Max	Unit
Input voltage	H-level	V _{IH}	_	-	1.8 to 2.3	0.7 × V _{CC}		V
Input voltage	L-level	V _{IL}	_	_	1.8 to 2.3	_	0.2 × V _{CC}	V
	H-level	VoH	V _{IN} = V _{IH} or V _{IL}	I _{OH} = -100 μA	1.8	VCC - 0.2	_	
Output voltage				I _{OH} = -6 mA	71.8	1.4	_	V
	L-level	\/a.	V. V. or V.	I _{OL} = 100 μA	1.8	_	0.2	
	L-ievei	V _{OL}	$V_{IN} = V_{IH}$ or V_{IL}	I _{OL} = 6 mA	1.8	_	0.3	
Input leakage currer	put leakage current I _{IN} V _{IN} = 0 to 3.6 V			1.8	-	±5.0	μА	
3-state output OFF	state current	l _{OZ}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = 0 \text{ to } 3.6 \text{ V}$		1.8		±10.0	μА
Power-off leakage c	urrent	loff	$V_{IN}, V_{OUT} = 0 \text{ to } 3.6 \text{ V}$		0		> 10.0	μΑ
Quiescent supply current		laa	$V_{IN} = V_{CC}$ or GND		1.8	74	20.0	μА
		Icc	$V_{CC} \le (V_{IN}, V_{OUT}) \le 3.6$	V	1.8	9	±20.0	μΛ

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AC Characteristics (Ta = –40 to 85°C, input: $t_r = t_f$ = 2.0 ns, C_L = 30 pF, R_L = 500 Ω) (Note 1)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
			1.8	100	_	
Maximum clock frequency	f _{max}	Figure 1, Figure 2	2.5 ± 0.2	200	_	MHz
			3.3 ± 0.3	250	_	
B 6 11 6			1.8	1.5	8.8	
Propagation delay time	t _{pLH}	Figure 1, Figure 2	2.5 ± 0.2	1.0	4.4	ns
(CK-Q)	t _{pHL}	< ((3.3 ± 0.3	0.8	3.5	
	4		1.8	1.5	9.8	
3-state output enable time	t _{pZL}	Figure 1, Figure 3	2.5 ± 0.2	1.0	4.9	ns
	t _{pZH}		3.3 ± 0.3	0.8	3.8	
	t _{pLZ}	2()	1.8	1(5	7.6	ns
3-state output disable time		Figure 1, Figure 3	2.5 ± 0.2	1.0	4.2	
	t _{pHZ}	$(\langle // \rangle)^{*}$	3.3 ± 0.3	0.8	3.7	
Minimum pulse width	*	Figure 1, Figure 2	1.8	4.0) —	
(CK)	t _{W (H)}		2.5 ± 0.2	1.5		ns
(CK)			3.3 ± 0.3	1.5		
Minimum setup time			1.8	2.5		
(D, CKEN)	ts	Figure 1, Figure 2, Figure 4	2.5 ± 0.2	1.5		ns
(D, CKLIV)			3.3 ± 0.3	1.5		
Minimum hold time (D, CKEN)	/		1.8	1.0		
	t _h	Figure 1) Figure 2, Figure 4	2.5 ± 0.2	1.0		ns
			3.3 ± 0.3	1.0	_	
			1.8	_	0.5	
Output to output skew	tosLH	(Note 2)	2.5 ± 0.2	_	0.5	ns
	tosHL		3.3 ± 0.3	_	0.5	

Note 1: For $C_L = 50$ pF, add approximately 300 ps to the AC maximum specification.





Dynamic Switching Characteristics (Ta = 25°C, input: t_r = t_f = 2.0 ns, C_L = 30 pF, R_L = 500 Ω)

Characteristics	Symbol	Test Condition			Тур.	Unit
	,			V _{CC} (V)		
		V _{IH} = 1.8 V, V _{IL} = 0 V	(Note)	1.8	0.25	
Quiet output maximum dynamic V _{OL}	V_{OLP}	$V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	2.5	0.6	V
		$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	(Note)	3.3	0.8	•
		V _{IH} = 1.8 V, V _{IL} = 0 V	(Note)	1.8	-0.25	
Quiet output minimum dynamic V _{OI}	V _{OLV}	V _{IH} = 2.5 V, V _{IL} = 0 V	(Note)	2.5	-0.6	V
		V _{IH} = 3.3 V, V _{IL} = 0 V	(Note)	3.3	-0.8	
		V _{IH} = 1.8 V, V _{IL} = 0 V	(Note)	1.8	1.5	
Quiet output minimum dynamic V _{OH}		V _{IH} = 2.5 V, V _{IL} = 0 V	(Note)	2.5	1.9	V
		V _{IH} = 3.3 V, V _{IL} = 0 V	(Note)	3.3	2.2	

Parameter guaranteed by design. Note:

Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition		V _{CC} (V)	Тур.	Unit
Input capacitance	C _{IN}		$\langle // \rangle$	1.8, 2.5, 3.3	6	pF
Output capacitance	CO	~ · ·		1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	C _{PD}	f _{IN} = 10 MHz	(Note)	1.8, 2.5, 3.3	60	pF

CPD is defined as the value of the internal equivalent capacitance which is calculated from the operating Note: current consumption without load.

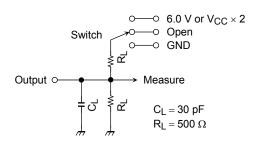
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Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/20 \text{ (per bit)}$



AC Test Circuit



Parameter	Switch		
t _{pLH} , t _{pHL}	Open		
t _{pLZ} , t _{pZL}	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$		
t _{pHZ} , t _{pZH}	GND		

Figure 1

AC Waveform

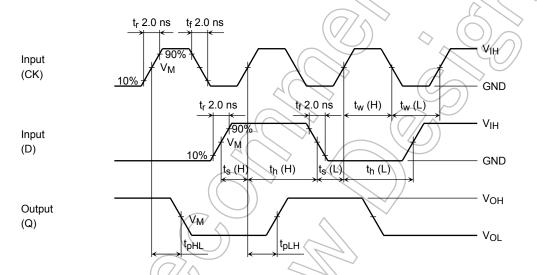


Figure 2 tplH, tpHL, tw, ts, th

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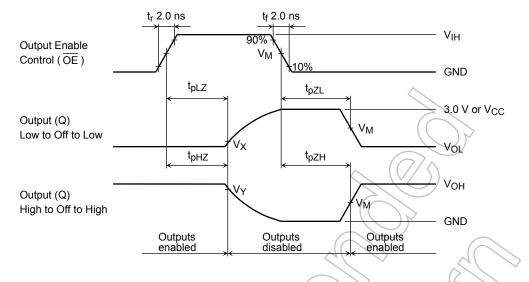


Figure 3 t_{pLZ} , t_{pHZ} , t_{pZL} , t_{pZH}

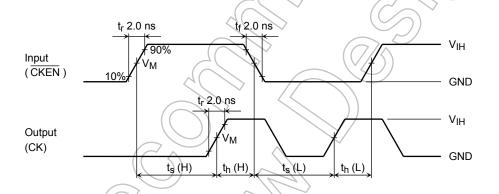
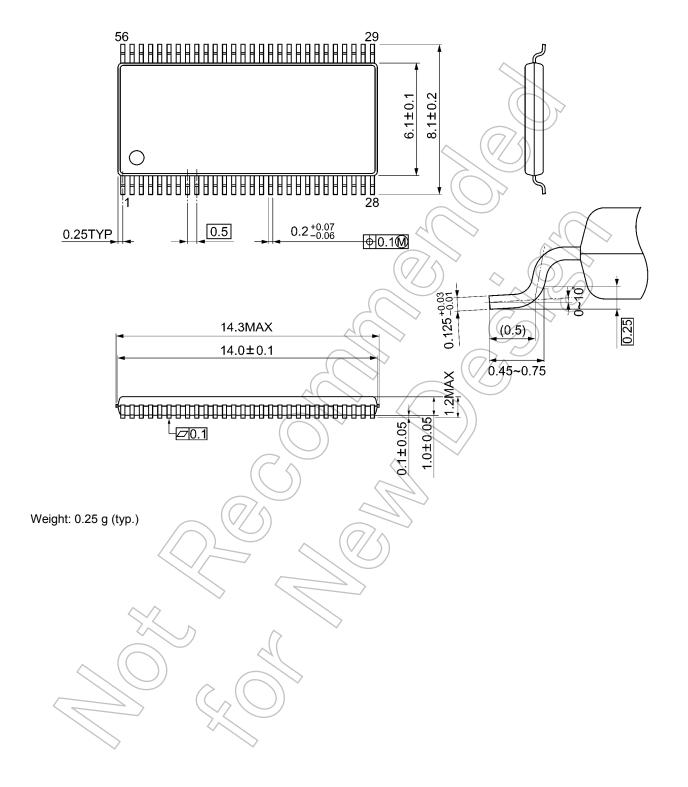


Figure 4 ts, th

Symbol	Vcc						
Symbol	3.3 ± 0.3 V	2.5 ± 0.2 V	1.8 V				
V_{IH}	2.7 V	V _{CC}	V _{CC}				
V_{M}	1.5 V	V _{CC} /2	V _{CC} /2				
V_X	V _{OL} + 0.3 V	V _{OL} + 0.15 V	V _{OL} + 0.15 V				
VY	V _{OH} – 0,3 V	V _{OH} – 0.15 V	V _{OH} – 0.15 V				

Package Dimensions

TSSOP56-P-0061-0.50A Unit: mm



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